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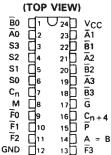
- Full Look-Ahead for High-Speed Operations on Long Words
- Input Clamping Diodes Minimize Transmission-Line Effects
- Darlington Outputs Reduce Turn-Off Time
- Arithmetic Operating Modes:

Addition
Subtraction
Shift Operand A One Position
Magnitude Comparison
Plus Twelve Other Arithmetic
Operations

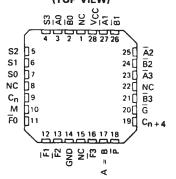
Logic Function Modes:

Exclusive-OR
Comparator
AND, NAND, OR, NOR
Plus Ten Other Logic Operations

SN54LS181, SN54S181 . . . J OR W PACKAGE SN74LS181, SN74S181 . . . DW OR N PACKAGE



SN54LS181, SN54S181 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

TYPICAL ADDITION TIMES

NUMBER	ADDITI	ON TIMES	PA	CKAGE COUNT	CARRY METHOD
OF	USING 'LS181	USING 'S181	ARITHMETIC/	LOOK-AHEAD	BETWEEN
BITS	AND 'S182	AND 'S182	LOGIC UNITS	CARRY GENERATORS	ALUs
1 to 4	24 ns	11 ns	1		NONE
5 to 8	40 ns	18 ns	2		RIPPLE
9 to 16	44 ns	19 ns	3 or 4	1	FULL LOOK-AHEAD
17 to 64	68 ns	28 ns	5 to 16	2 to 5	FULL LOOK-AHEAD

description

The 'LS181 and 'S181 are arithmetic logic units (ALU)/function generators that have a complexity of 75 equivalent gates on a monolithic chip. These circuits perform 16 binary arithmetic operations on two 4-bit words as shown in Tables 1 and 2. These operations are selected by the four function-select lines (S0, S1, S2, S3) and include addition, subtraction, decrement, and straight transfer. When performing arithmetic manipulations, the internal carries must be enabled by applying a low-level voltage to the mode control input (M). A full carry look-ahead scheme is made available in these devices for fast, simultaneous carry generation by means of two cascade-outputs (pins 15 and 17) for the four bits in the package. When used in conjunction with the SN54S182 or SN74S182 full carry look-ahead circuits, high-speed arithmetic operations can be performed. The typical addition times shown above illustrate the little additional time required for addition of longer words when full carry look-ahead is employed. The method of cascading 'S182 circuits with these ALUs to provide multi-level full carry look-ahead is illustrated under typical applications data for the 'S182.

If high speed is not of importance, a ripple-carry input (C_n) and a ripple-carry output (C_{n+4}) are available. However, the ripple-carry delay has also been minimized so that arithmetic manipulations for small word lengths can be performed without external circuitry.



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description (continued)

The 'LS181 and 'S181 will accommodate active-high data if the pin designations are interpreted as follows:

PIN NUMBER	2	1	23	22	21	20	19	18	9	10	11	13	7	16	15	17
Active-low data (Table 1)	\overline{A}_0	B ₀	Ā ₁	B ₁	Ā ₂	B̄2	Ā3	Вз	F٥	F ₁	F ₂	F ₃	Cn	Cn+4	P	G
Active-high data (Table 2)	A ₀	B ₀	A ₁	B ₁	A ₂	B ₂	Аз	Вз	Fo	F ₁	F ₂	F ₃	Cn	Cn+4	Х	Υ

Subtraction is accomplished by 1's complement addition where the 1's complement of the subtrahend is generated internally. The resultant output is A-B-1, which requires an end-around or forced carry to provide A-B.

The 'LS181 or 'S181 can also be utilized as a comparator. The A=B output is internally decoded from the function outputs (F0, F1, F2, F3) so that when two words of equal magnitude are applied at the A and B inputs, it will assume a high level to indicate equality (A=B). The ALU must be in the subtract mode with $C_{n}=H$ when performing this comparison. The A=B output is open-collector so that it can be wire-AND connected to give a comparison for more than four bits. The carry output (C_{n+4}) can also be used to supply relative magnitude information. Again, the ALU must be placed in the subtract mode by placing the function select inputs S3, S2, S1, S0 at L, H, H, L, respectively.

INPUT Cn	OUTPUT C _{n+4}	ACTIVE-LOW DATA (FIGURE 1)	ACTIVE-HIGH DATA (FIGURE 2)
Н	н	A ≥ B	A ≤ B
н	L	A < B	A > B
L	н	A > B	A < B
L	L	A ≤ B	A ≥ B

These circuits have been designed to not only incorporate all of the designer's requirements for arithmetic operations, but also to provide 16 possible functions of two Boolean variables without the use of external circuitry. These logic functions are selected by use of the four function-select inputs (S0, S1, S2, S3) with the mode-control input (M) at a high level to disable the internal carry. The 16 logic functions are detailed in Tables 1 and 2 and include exclusive-OR, NAND, AND, NOR, and OR functions.

Series 54, 54LS, and 54S devices are characterized for operation over the full military temperature range of -55°C to 125°C; Series 74LS and 74S devices are characterized for operation from 0°C to 70°C.

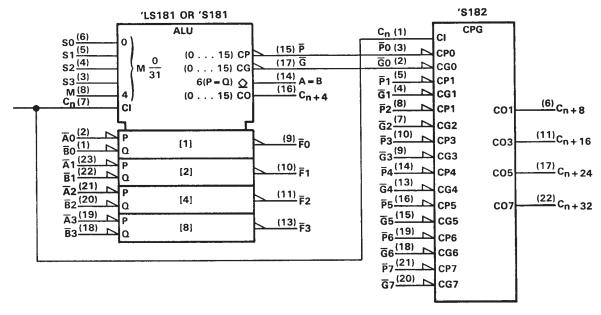
signal designations

In both Figures 1 and 2, the polarity indicators (\triangle) indicate that the associated input or output is active-low with respect to the function shown inside the symbol, and the symbols are the same in both figures. The signal designations in Figure 1 agree with the indicated internal functions based on active-low data, and are for use with the logic functions and arithmetic operations shown in Table 1. The signal designations have been changed in Figure 2 to accommodate the logic functions and arithmetic operations for the active-high data given in Table 2. The 'LS181 and 'S181, together with the 'S182, can be used with the signal designation of either Figure 1 or Figure 2.



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logic symbols[†] and signal designations (active-low data)



[†]These symbols are in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12. Pin numbers shown are for dual-in-line and "small outline" packages.

FIGURE 1 (USE WITH TABLE 1)

TABLE 1

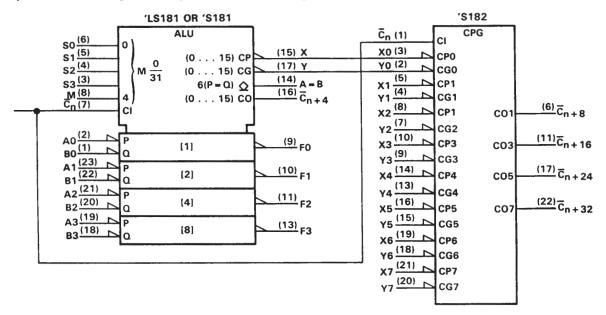
	051.5	271011			ACTIVE-LOW DA	TA
	SELE	CTION		M = H	M = L; ARITHM	IETIC OPERATIONS
S3	S2	S1	S0	LOGIC	Cn = L	Cn = H
				FUNCTIONS	(no carry)	(with carry)
L	Ļ	L	L	F=A	F = A MINUS 1	F = A
L	L	L	н	F = AB	F = AB MINUS 1	F = AB
L	L	Н	L	F = A + B	F = AB MINUS 1	F = AB
L	L	Н	Н	F = 1	F = MINUS 1 (2's COMP)	F = ZERO
L	Н	L	L	F = A + B	F = A PLUS (A + B)	F = A PLUS (A + B) PLUS 1
L	н	L	н	F = B	F = AB PLUS (A + B)	F = AB PLUS (A + B) PLUS 1
L	н	н	L.	F = A + B	F = A MINUS B MINUS 1	F = A MINUS B
L	н	н	н	F = A + B	F = A + B	F = (A + B) PLUS 1
н	L	L	L	F = AB	F = A PLUS (A + B)	F = A PLUS (A + B) PLUS 1
н	L	L	Н	F = A ⊕ B	F = A PLUS B	F = A PLUS B PLUS 1
Н	L	Н	L	F=B	F = AB PLUS (A + B)	F = AB PLUS (A + B) PLUS 1
Н	L	н	н	F = A + B	F = (A + B)	F = (A + B) PLUS 1
н	н	L,	L	F=0	F = A PLUS A [‡]	F = A PLUS A PLUS 1
н	н	L	н	F ≈ AB	F = AB PLUS A	F = AB PLUS A PLUS 1
Н	н	Н	L	F = AB	F = AB PLUS A	F = AB PLUS A PLUS 1
н	н	н	н	F = A	F = A	F = A PLUS 1

[‡]Each bit is shifted to the next more significant position.



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logic symbols[†] and signal designations (active-high data)



[†]These symbols are in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12. Pin numbers shown are for dual-in-line and "small outline" packages.

FIGURE 2 (USE WITH TABLE 2)

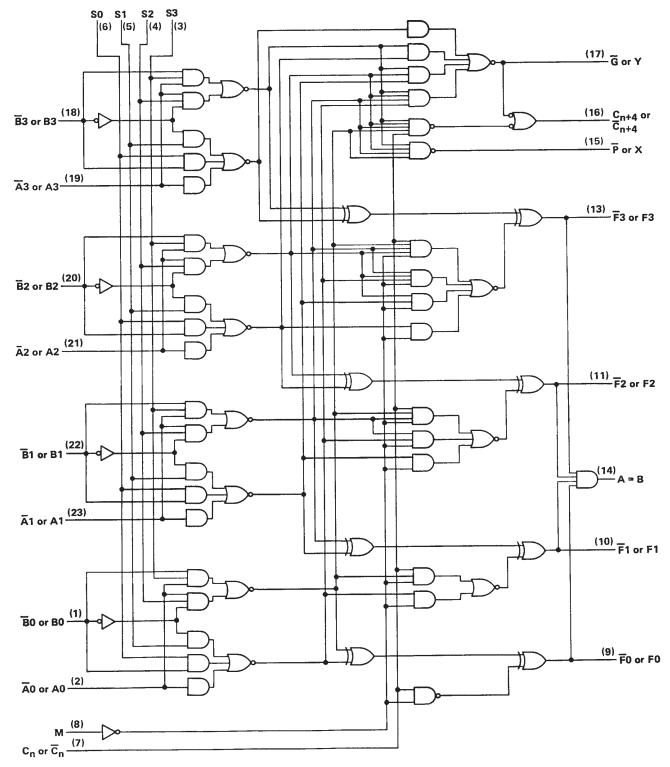
TABLE 2

	051.5	OTION			ACTIVE-HIGH DA	TA
	2FFF(CTION		M = H	M = L; ARITHM	ETIC OPERATIONS
S3	S2	S1	S0	LOGIC FUNCTIONS	C _n = H (no carry)	C _n = L (with carry)
L	L	L	L	F = A	F = A	F = A PLUS 1
L	L	L	Н	F = A + B	F = A + B	F = (A + B) PLUS 1
L	L	н	L	F = AB	F = A + B	$F = (A + \overline{B}) PLUS 1$
L	L	н	н	F=0	F = MINUS 1 (2's COMPL)	F = ZERO
L	Н	L	L	F = AB	F = A PLUS AB	F = A PLUS AB PLUS 1
L	Н	L	Н	F=B	F = (A + B) PLUS AB	F = (A + B) PLUS AB PLUS 1
L,	н	н	L	F = A (+) B	F = A MINUS B MINUS 1	F = A MINUS B
L	н	н	Н	F = AB	F = AB MINUS 1	F = AB
н	L	L	L	F = A + B	F = A PLUS AB	F = A PLUS AB PLUS 1
н	L	L	н	F = A ⊕ B	F = A PLUS B	F = A PLUS B PLUS 1
н	L	н	L	F=B	F = (A + B) PLUS AB	F = (A + B) PLUS AB PLUS 1
Н	L	н	н	F = AB	F = AB MINUS 1	F = AB
Н	Н	L	L	F = 1	F = A PLUS A†	F = A PLUS A PLUS 1
н	н	L	н	$F = A + \overline{B}$	F = (A + B) PLUS A	F = (A + B) PLUS A PLUS 1
н	н	н	L	F = A + B	F = (A + B) PLUS A	$F = (A + \overline{B})$ PLUS A PLUS 1
н	н	н	н	F=A	F = A MINUS 1	F = A

 $[\]ensuremath{^{\dagger}}$ Each bit is shifted to the next more significant position.



logic diagram (positive logic)



Pin numbers shown are for DW, J, N, and W packages.



SN54LS181, SN54S181 SN74LS181, SN74S181

ARITHMETIC LOGIC UNITS/FUNCTION GENERATORS

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abso	lute maximum ratings over reco	mı	me	enc	dec	o b	pe	rat	ing	g f	ree)-a	ir 1	ter	np	era	atu	re	raı	nge) (un	le	SS	ot	he	rw	/ise	n	oted)
	Supply voltage, V _{CC} (see Note 1)																													7١	/
	Input voltage																													5.5 \	/
	Interemitter voltage (see Note 2)																													5.5 \	/
	Operating free-air temperature range:	: 5	SN	54	LS	18	1																			— 5	55°	°C 1	o '	125°()
		5	SN	74	LS	18	1																				(o°C	to	70°0	2
	Storage temperature range																									-6	35°	C 1	o '	150°0	:

NOTES: 1. Voltage values, except interemitter voltage, are with respect to network ground terminal.

2. This is the voltage between two emitters of a multiple-emitter transistor. For this circuit, this rating applies to each \bar{A} input in conjunction with inputs S2 or S3, and to each \vec{B} input in conjunction with inputs S0 or S3.

recommended operating conditions

	SI		81	SN	174LS1	81	
	MIN	NOM	MAX	MIN	NOM	MAX	רואט
Supply voltage, V _{CC}	4.5	5	5.5	4.75	5	5.25	٧
High-level output current, IOH (All outputs except A = B)			-400			-400	μΑ
Low-level output current, IOL			4			8	mA
Operating free-air temperature, T _A	-55		125	0		70	°c

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	BABAI	METER	750	T CONDITIONS	·†	Si	N54LS1	B1	Si	N74LS1	81	UNIT
	FARA	VIETER	153	or COMBILIONS	••	MIN	TYP‡	MAX	MIN	TYP‡	MAX	וואטן
V_{IH}	High-level in	put voltage				2			2			V
VIL	Low-level in	put voltage						0.7			0.8	V
VIK	Input clamp	voltage	V _{CC} = MIN,	I _I = -18 mA				-1.5			-1.5	V
Vон		utput voltage, except A = B	V _{CC} = MIN, V _{IL} = V _{IL} max,	V _{IH} = 2 V, I _{OH} = -400 μA		2.5	3.4		2.7	3.4		٧
ЮН	High-level o	utput current, it only	V _{CC} = MIN, V _{1L} = V _{1L} max,	***	····			100			100	μΑ
		A.H			IOL = 4 mA		0.25	0.4		0.25	0.4	
.,	Low-level	All outputs	V _{CC} = MIN,	V _{IH} = 2 V,	IOL = 8 mA					0.35	0.5	1
VOL	output	Output G	VIL = VIL max		I _{OL} = 16 mA		0.47	0.7		0.47	0.7	٧
	voltage	Output P			IOL = 8 mA		0.35	0.6		0.35	0.5	
	Input	Mode input						0.1			0.1	
	current at	Any A or Binput	VMAY	V - 5 5 V				0.3			0.3	
Ч	max, input	Any S input	V _{CC} = MAX,	V = 5.5 V				0.4			0.4	mA
	voltage	Carry input						0.5			0.5	
	High-level	Mode input						20			20	
1	•	Any A or B input	V	V 0.7.V				60			60	
11H	input	Any S input	V _{CC} = MAX,	V = 2.7 V				80			80	μΑ
	current	Carry input						100		,	100	
	Low-level	Mode input						-0.4			-0.4	
L	input	Any A or B input	V _{CC} = MAX,	V. = 0.4 V				-1.2			-1.2	
IIL		Any S input	VCC - WAA,	V - 0.4 V				-1.6			-1.6	mA
	current	Carry input						-2			-2	
los		t output current, except A = B §	V _{CC} = MAX			-6		-40	-5		-42	mA
laa	Supply curre	n#	Van = MAX	See Note 2	Condition A		20	32		20	34	^
ICC	oupply curre	ent	V _{CC} = MAX,	See Note 3	Condition B		21	35		21	37	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

B. S0 through S3 and M are at 4.5 V, all other inputs are grounded.



 $^{^{\}ddagger}$ All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}$ C.

[§] Not more than one output should be shorted at a time.

NOTE 3: With outputs open, I_{CC} is measured for the following conditions:

A. S0 through S3, M, and \overline{A} inputs are at 4.5 V, all other inputs are grounded.

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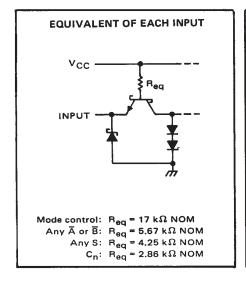
switching characteristics, VCC = 5 V, TA = 25°C, (CL = 15 pF, RL = 2 k Ω , see note 4)

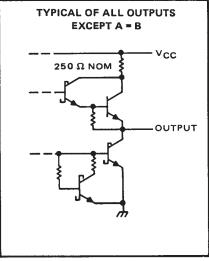
PARAMETER [†]	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
^t PLH	6	_			18	27	ns
tPHL	C _n	C _{n+4}			13	20	113
t _{PLH}	Any \overline{A} or \overline{B}	<u> </u>	M = 0 V, S0 = S3 = 4.5 V,		25	38	ns
^t PHL	Any A or B	C _{n+4}	S1 = S2 = 0 V (SUM mode)		25	38] ""
tPLH	Any A or B	<u> </u>	M = 0 V, S0 = S3 = 0 V		27	41	ns
^t PHL	Ally A or B	C _{n+4}	S1 = S2 = 4.5 V (DIFF mode)		27	41	113
tPLH		۵ 7	M = 0 V		17	26	ns
tPHL	C _n	Any F	(SUM or DIFF mode)		13	20	1113
t _{PLH}	Any A or B	Ğ	M = 0 V, S0 = S3 = 4.5 V,		19	29	ns
tPHL	Any A or B	"	$S1 = S2 = 0 V (\overline{SUM} \text{ mode})$		15	23] '''
tPLH .		Ğ	M = 0 V, S0 = S3 = 0 V,		21	32	
tPHL	Any A or B	G	S1 = S2 = 4.5 V (DIFF mode)		21	32	ns
tPLH		P	M = 0 V, S0 = S3 = 4.5 V,		20	30	
[†] PHL	Any A or B		S1 = S2 = 0 V, (SUM mode)		20	30	ns
^t PLH	A	Ē	M = 0 V, S0 = S3 = 0 V,		20	30	ns
tPHL	Any \overline{A} or \overline{B}		S1 = S2 = 4.5 V (DIFF mode)		22	33	113
t _{PLH}	Ā _i or B _i	Fi	M = 0 V, S0 = S3 = 4.5 V,		21	32	ns
t _{PHL}	A _i or B _i	"i	S1 = S2 = 0 V (SUM mode)		13	20	113
tPLH	Λ D.	F _i	M = 0 V, S0 = S3 = 0 V,		21	32	ns
tPHL.	¦or Bi	Fi	S1 = S2 = 4.5 V (DIFF mode)		21	32] '''
[†] PLH	Ā _i or B̄ _i	F _i	M = 4.5 V (logic mode)		22	33	ns
tPHL.	Aiorbi	Fi	IVI - 4.5 V (logic mode)		26	38	113
^t PLH	Anu 7 os 7	A = B	M = 0 V, S0 = S3 = 0 V,		33	50	ns
tPHL	Any A or B	A - B	S1 = S2 = 4.5 V (DIFF mode)		41	62	113

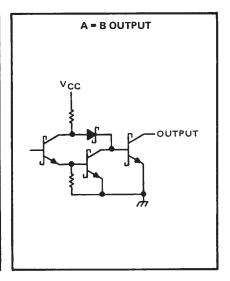
[†]tpLH = propagation delay time, low-to-high-level output

NOTE 4: Load circuits and voltage wveforms are shown in Section 1. Refer to Parameter Measurement Information page for test conditions.

schematics of inputs and outputs







tpHL = propagation delay time, high-to-low-level output

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see Note 1)																	7 V	1
Input voltage																	5.5 V	1
Interemitter voltage (see Note 2)																	5.5 V	•
Operating free-air temperature: SN54S181													!	55°	C	to	125°C)
SN74S181	I													() C	C to	o 70°C	7
Storage temperature range													-1	65°	C.	to	150°C	;

NOTES: 1. Voltage values, except interemitter voltage, are with respect to network ground terminal.

2. This is the voltage between two emitters of a multiple-emitter transistor. For this circuit, this rating applies to each 🛱 input in conjunction with inputs S2 or S3, and to each $\overline{\mbox{B}}$ input in conjunction with inputs S0 or S3.

recommended operating conditions

	S	N54S18	31	5	N74S18	31	UNIT
	MIN	MOM	MAX	MIN	NOM	MAX	ONT
Supply voltage, VCC	4.5	5	5.5	4.75	5	5.25	V
High-level output current, IOH (All outputs except A = B)			-1			-1	mA
Low-level output current, IOI			20			20	mΑ
Operating free-air temperature, TA	-55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

					+	S	N54S18	31	S	N74S18	31	UNIT
	PARAN	/IETER	TE	ST CONDITIONS	•	MIN	TYP [‡]	MAX	MIN	TYP [‡]	MAX	UNIT
VIH	High-level in	put voltage				2			2			V
VIL	Low-level in	put voltage						8.0			0.8	٧
VIK	Input clamp	voltage	V _{CC} = MIN,	I _I = -18 mA				-1.2			-1.2	٧
Vон	•	utput voltage, except A = B	V _{CC} = MIN, V _{IL} = 0.8 V,	V _{IH} = 2 V, I _{OH} = -1 mA		2.5	3.4		2.7	3.4		٧
Іон	High-level or A = B output	utput current,		V _{IH} = 2 V,				250			250	μА
V _{OL}	Low-level or	utput voltage	V _{CC} = MIN, V _{IL} = 0.8 V,	V _{IH} = 2 V, I _{OL} = 20 mA				0.5			0.5	٧
ij	Input currer		V _{CC} = MAX,	V _I = 5.5 V				1			1	mA
		Mode input						50			50	
	High-level	Any A or B input	1	V - 2 F V				150			150	μА
ΉН	input	Any S input	V _{CC} = MAX,	V ₁ = 2.5 V				200			200] ~~
	current	Carry input	1					250			250	
		Mode input						-2			-2	
	Low-level	Any A or B input		V 0 E V				-6			-6	mA
IIL	input	Any S input	V _{CC} = MAX,	V = 0.5 V				-8			-8] ""`
	current	Carry input	1					-10			-10	ļ
los		t output current, except A = B §	V _{CC} = MAX			-40		-100	-40		-100	mA
Icc	Supply curr	ent	V _{CC} = MAX, See Note 3	T _A = 125°C,	W package only			195				mA
			V _{CC} = MAX,	See Note 3	All packages		120	220		120	220	<u> </u>

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



 $[\]ddagger$ AII typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

[§]Not more than one output should be shorted at a time.

NOTE 3: I_{CC} is measured for the following conditions (the typical and maximum values apply to both):

A. S0 through S3, M, and \overline{A} inputs are at 4.5 V, all other inputs are grounded, and all outputs are open.

B. S0 through S3 and M are at 4.5 V, all other inputs grounded, and all outputs are open.

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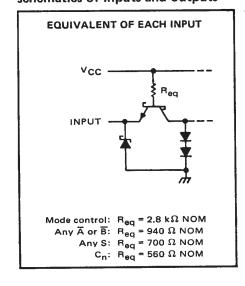
switching characteristics, V_{CC} = 5 V, T_A = 25°C (C_L = 15 pF, R_L = 280 Ω , see note 4)

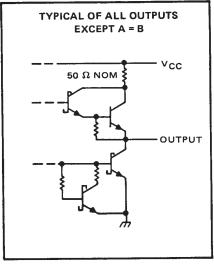
PARAMETER†	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
tPLH		C				10.5	ns	
tPHL	C _n	C _{n+4}			7	10.5		
^t PLH	Any Ā or B	C	M = 0 V, S0 = S3 = 4.5 V,		12.5	18.5	ns	
^t PHL	Any A or B	C _{n+4}	S1 = S2 = 0 V (SUM mode)		12.5	18.5		
^t PLH	Any A or B	C _{n+4}	M = 0 V, S0 = S3 = 0 V,		15.5	23	ns	
†PHL	Any A or B	On+4	S1 = S2 = 4.5 V (DIFF mode)		15.5	23		
^t PLH		Any F	M = 0 V		7	12	ns	
tPHL	C _n	Anyr	(SUM or DIFF mode)		7	12		
^t PLH	A 7 7	G	M = 0 V, S0 = S3 = 4.5 V,		8	12	ns	
tPHL	Any \overline{A} or \overline{B}		S1 = S2 = 0 V (SUM mode)		7.5	12		
tPLH		G	M = 0 V, S0 = S3 = 0 V,		10.5	15	ns	
tPHL	Any Ā or B		S1 = S2 = 4.5 V (DIFF mode)		10.5	15		
tPLH	A 7 7	P	M = 0 V, S0 = S3 = 4.5 V,		7.5		ns	
tPHL	Any A or B		S1 = S2 = 0 V (SUM mode)		7.5	12		
tPLH	4 7 5	P	M = 0 V, S0 = S3 = 0 V,		10.5	15	ns	
tPHL	Any Ā or B		S1 = S2 = 4.5 V (DIFF mode)		10.5	15	1	
tPLH		F;	M = 0 V, S0 = S3 = 4.5 V,		11	16.5	ns	
tPHL	\overline{A}_i or \overline{B}_i	ri	$S1 = S2 = 0 V (\overline{SUM} \text{ mode})$		11	16.5		
tPLH		_	M = 0 V, S0 = S3 = 0 V,		14	20	ns	
tPHL.	$\overline{A_i}$ or $\overline{B_i}$	Fi	S1 = S2 = 4.5 V (DIFF	S1 = S2 = 4.5 V (DIFF mode)		14	22	7 "
tPLH		-	F: M = 4.5 V (logic mode)		14	20	ns	
tPHL	Ā _i or \overline{B}_i	F _i	ivi = 4.5 v (logic mode)		14	22		
tPLH		A . D	M = 0 V, S0 = S3 = 0 V,		15	23	ns	
tPHL	Any A or B	A = B	S1 = S2 = 4.5 V (DIFF mode)		20	30	7 '''	

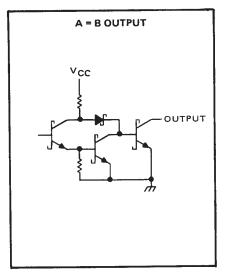
 $^{^{\}dagger}$ tpLH = propagation delay time, low-to-high-level output

NOTE 4: Load circuits and voltage wveforms are shown in Section 1. Refer to Parameter Measurement Information page for test conditions.

schematics of inputs and outputs







tpHL = propagation delay time, high-to-low-level output

SDLS136 - DECEMBER 1972 - REVISED MARCH 1988

PARAMETER MEASUREMENT INFORMATION

SUM MODE TEST TABLE

FUNCTION INPUTS: S0 = S3 = 4.5 V, S1 = S2 = M = 0 V

	INPUT	OTHER		OTHER DA	TA INPUTS	OUTPUT	OUTPUT WAVEFORM
PARAMETER	TEST	APPLY 4.5 V	APPLY GND	APPLY 4.5 V	APPLY GND	TEST	(See Note 4)
tPLH tPHL	Āi	≅ _i	None	Remaining A and B	Cn	Fi	In-Phase
^t PLH ^t PHL	Bi	Āi	None	Remaining A and B	Cn	F;	In-Phase
tPLH tPHL	Āi	Bi	None	None	Remaining Ā and B, C _n	P	In-Phase
tPLH TPHL	Bi	Āi	None	None	Remaining Ā and B, C _n	Ā	In-Phase
tPLH tPHL	Āi	None	B _i	Remaining B	Remaining A, C _n	G	In-Phase
tPLH tPHL	Bi	None	Āi	Remaining B	Remaining Ā, C _n	G	In-Phase
tPLH tPHL	Cn	None	None	AII Ā	AII B	Any F or C _{n+4}	In-Phase
tPLH tPHL	Āi	None	Bi	Remaining B	Remaining A, C _n	C _{n+4}	Out-of-Phase
t _{PLH}	Bi	None	Āi	Remaining B	Remaining A, C _n	Cn+4	Out-of-Phase

DIFF MODE TEST TABLE FUNCTION INPUTS: S1 = S2 = 4.5 V, S0 = S3 = M = 0 V

					, 00 - 00 -			
242445752	INPUT	OTHER INPUT SAME BIT		OTHER DA	TA INPUTS	OUTPUT	OUTPUT WAVEFORM	
PARAMETER	UNDER	APPLY	APPLY	APPLY	APPLY	TEST	(See Note 4)	
	TEST	4.5 V	GND	4.5 V	GND	1531		
tPLH	Ā,	None	ne B;	Remaining	Remaining	F _i	In-Phase	
tPHL .		IAOUE	٥,	Ā	B, C _n	''		
tPLH .	B _i	Āi	None	Remaining	Remaining	F;	Out-of-Phase	
tPHL.	,		IVONE	Ā	B, C _n	''	Out-or-mase	
^t PLH	Āi	None	₿ _i	None	Remaining	P	In-Phase	
tPHL .	' '	MOUR	, s	None	A and B, C _n	'		
^t PLH	Ē;	Āį	None	None None	Remaining	Ē	Out-of-Phase	
^t PHL	P _i	^'	140116	None	\overline{A} and \overline{B} , C_n	<u>'</u>		
tPLH .	Āi	B _i	None	None	Remaining	G	In-Phase	
tPHL	^ '	P1	None		\overline{A} and \overline{B} , C_n			
tPLH .	Bi	None	lone Ā _i	None	Remaining	G	Out-of-Phase	
^t PHL) "	140118	~'	140116	A and B, C _n		out of this	
^t PLH	Āį	None	Bi	Remaining	Remaining	A = B	In-Phase	
tPHL.	1	140116	"	Ā	⊞, C _n	'' -		
^t PLH	8;	Āi	None	Remaining	Remaining	A = B	Out-of Phase	
tPHL .	1 "	^'	110/10	Ā	B, C _n		20. 37 1 11030	
[†] PLH	C _n	None	None	_ All _	None	Cn+4	In-Phase	
^t PHŁ	l ^o n	140.110	1,40.1.0	A and B		or any F	III I Nasc	
^t PLH	Āį	B _i	R: None	None	Remaining	Cn+4	Out-of-Phase	
tPHL.		D,	1400		Ā, B, C _n	-1174		
^t PLH	Bi	B; None		None	Remaining	Cn+4	In -Phase	
tPHL.	1 -'		Āi		A, B, C _n	.,,,,		

LOGIC MODE TEST TABLE FUNCTION INPUTS: S1 = S2 = M = 4.5 V, S0 = S3 = 0 V

	INPUT	OTHER INPUT		OTHER D	ATA INPUTS	OUTPUT	OUTPUT WAVEFORM
PARAMETER	UNDER TEST	APPLY 4.5 V	APPLY GND	APPLY 4.5 V	APPLY GND	TEST	(See Note 4)
tPLH tPHL	Āį	Bi	None	None	Remaining Ā and B, C _n	ř,	Out-of-Phase
¹PLH ¹PHL	B̄;	Āį	None	None	Remaining Ā and B, C _n	Fi	Out-of-Phase

NOTE 4: Load circuits and voltage waveforms are shown in Section 1.







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PACKAGING INFORMATION

	Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
		(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
,	JM38510/07801BJA	ACTIVE	CDIP	J	24	1	TBD	Call TI	N / A for Pkg Type	-55 to 125	JM38510/ 07801BJA	Samples
	M38510/07801BJA	ACTIVE	CDIP	J	24	1	TBD	Call TI	N / A for Pkg Type	-55 to 125	JM38510/ 07801BJA	Samples
	SN54LS181J	ACTIVE	CDIP	J	24	1	TBD	Call TI	N / A for Pkg Type	-55 to 125	SN54LS181J	Samples
	SN54S181J	ACTIVE	CDIP	J	24	1	TBD	Call TI	N / A for Pkg Type	-55 to 125	SN54S181J	Samples
	SN74LS181N3	OBSOLETE	PDIP	N	24		TBD	Call TI	Call TI	0 to 70		
	SN74S181J	OBSOLETE	CDIP	J	24		TBD	Call TI	Call TI	0 to 70		
	SN74S181N	OBSOLETE	PDIP	N	24		TBD	Call TI	Call TI	0 to 70		
	SN74S181N3	OBSOLETE	PDIP	N	24		TBD	Call TI	Call TI	0 to 70		
	SNJ54LS181J	ACTIVE	CDIP	J	24	1	TBD	Call TI	N / A for Pkg Type	-55 to 125	SNJ54LS181J	Samples
	SNJ54S181J	ACTIVE	CDIP	J	24	1	TBD	Call TI	N / A for Pkg Type	-55 to 125	SNJ54S181J	Samples
	SNJ54S181W	ACTIVE	CFP	W	24	1	TBD	A42	N / A for Pkg Type	-55 to 125	SNJ54S181W	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.





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- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF SN54LS181, SN54S181, SN74LS181, SN74S181:

Catalog: SN74LS181, SN74S181

Military: SN54LS181, SN54S181

NOTE: Qualified Version Definitions:

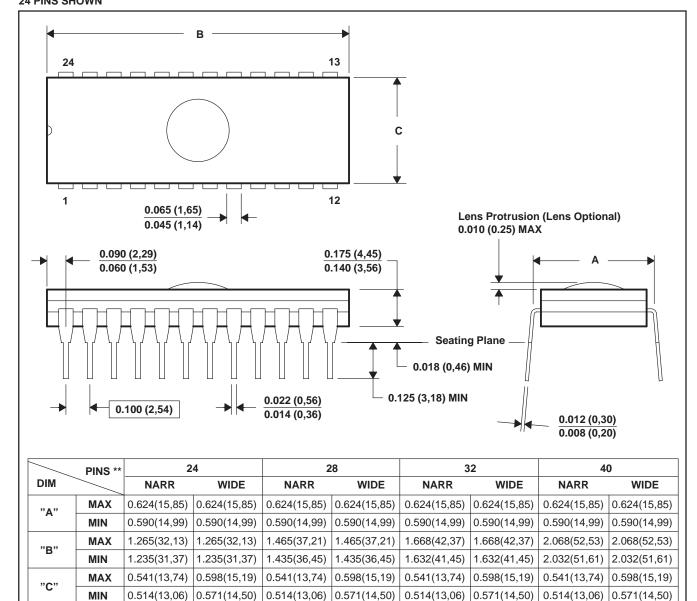
- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

4040084/C 10/97

J (R-GDIP-T**)

24 PINS SHOWN

CERAMIC DUAL-IN-LINE PACKAGE



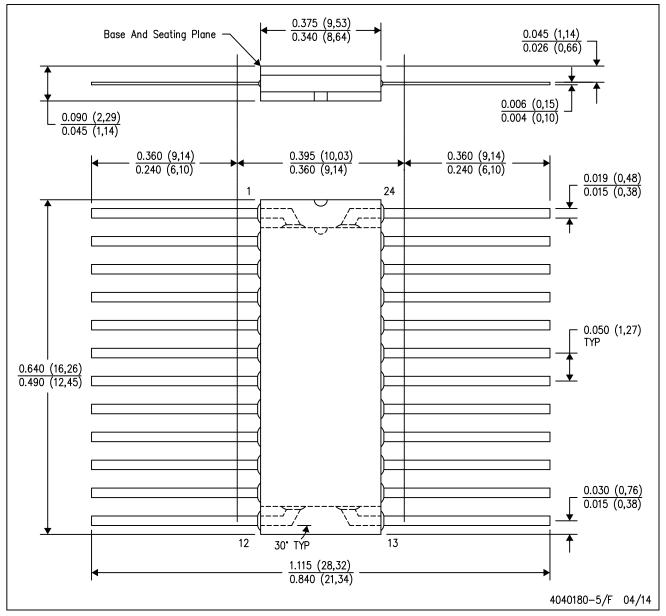
NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. Window (lens) added to this group of packages (24-, 28-, 32-, 40-pin).
- D. This package can be hermetically sealed with a ceramic lid using glass frit.
- E. Index point is provided on cap for terminal identification.



W (R-GDFP-F24)

CERAMIC DUAL FLATPACK



NOTES:

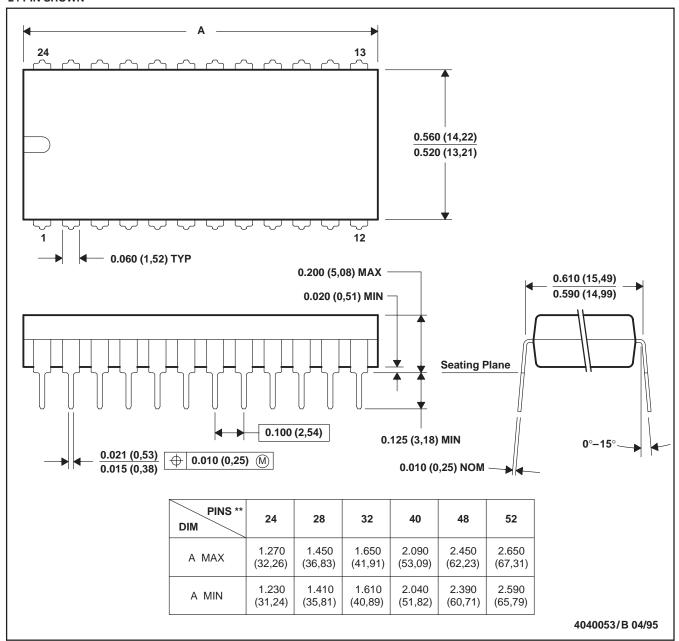
- A. All linear dimensions are in inches (millimeters).
- This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only. E. Falls within Mil—Std 1835 GDFP2—F20



N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

24 PIN SHOWN



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MS-011
- D. Falls within JEDEC MS-015 (32 pin only)



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